

NX3008CBKV

30 / 30 V, 400 / 220 mA N/P-channel Trench MOSFET Rev. 1 — 29 July 2011 Product

Product data sheet

1. **Product profile**

1.1 General description

Complementary N/P-channel enhancement mode Field-Effect Transistor (FET) in an ultra small and flat lead SOT666 Surface-Mounted Device (SMD) plastic package using Trench MOSFET technology.

1.2 Features and benefits

- Low threshold voltage
- Very fast switching
- Trench MOSFET technology
- ESD protection up to 2 kV
- AEC-Q101 qualified

1.3 Applications

- Level shifter
- Power supply converter

- Load switch
- Switching circuits

1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
TR2 (P-cha	annel)						
V_{DS}	drain-source voltage	T _j = 25 °C		-	-	-30	V
V_{GS}	gate-source voltage			-8	-	8	V
I_D	drain current	V_{GS} = -4.5 V; T_{amb} = 25 °C	[1]	-	-	-220	mA
TR1 (N-channel)							
V_{DS}	drain-source voltage	T _j = 25 °C		-	-	30	V
V_{GS}	gate-source voltage			-8	-	8	V
I_D	drain current	$V_{GS} = 4.5 \text{ V}; T_{amb} = 25 ^{\circ}\text{C}$	[1]	-	-	400	mA
TR1 (N-ch	annel), Static character	istics					
R _{DSon}	drain-source on-state resistance	$V_{GS} = 4.5 \text{ V}; I_D = 350 \text{ mA};$ $T_j = 25 \text{ °C}$		-	1	1.4	Ω
TR2 (P-channel), Static characteristics							
R _{DSon}	drain-source on-state resistance	V_{GS} = -4.5 V; I_{D} = -200 mA; T_{j} = 25 °C		-	2.8	4.1	Ω

^[1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and mounting pad for drain 1 cm².



2. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	S1	source TR1		
2	G1	gate TR1	6 5 4	D1 D2
3	D2	drain TR2		
4	S2	source TR2		$G1 \longrightarrow G2$
5	G2	gate TR2	1 2 3	
6	D1	drain TR1	SOT666 (SOT666)	S1 S2 017aaa262

3. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
NX3008CBKV	SOT666	plastic surface-mounted package; 6 leads	SOT666

4. Marking

Table 4. Marking codes

Type number	Marking code ^[1]
NX3008CBKV	AC

^[1] % = placeholder for manufacturing site code.

5. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

TR2 (P-chame-IV Vos drain-source voltage T _j = 25 °C - 30 V Vos gate-source voltage Vos = -4.5 V; T _{amb} = 25 °C 1 - 220 mA Ib drain current Vos = -4.5 V; T _{amb} = 100 °C 1 - 220 mA IbM peak drain current T _{amb} = 25 °C; single pulse; t _p ≤ 10 µs - 0.9 A Plot total power dissipation T _{amb} = 25 °C 2 - 30 mW TR1 (N-chamel) T _{amb} = 25 °C 2 - 30 mW Vos drain-source voltage T _j = 25 °C 2 - 30 mW Vos gate-source voltage T _j = 25 °C 2 - 30 W Vos gate-source voltage T _j = 25 °C 1 - 400 mA Vos drain current Vos = 4.5 V; T _{amb} = 25 °C 1 - 400 mA Ib drain current T _{amb} = 25 °C; single pulse; t _p ≤ 10 µs - 1.6 A Plot total power dissipation T _{amb} = 25 °C 1 - 30 mW Tamb = 25 °C 2 - 50 30 <th>Symbol</th> <th>Parameter</th> <th>Conditions</th> <th>Min</th> <th>Max</th> <th>Unit</th>	Symbol	Parameter	Conditions	Min	Max	Unit
VGS gate-source voltage -8 8 V ID drain current VGS = -4.5 V; Tamb = 25 °C 11 - 20 -220 mA IDM peak drain current Tamb = 25 °C; single pulse; tp ≤ 10 µs - 0.9 A Ptot total power dissipation Tamb = 25 °C 2 - 330 mW Ptot total power dissipation Tamb = 25 °C 2 - 330 mW Ptot Tamb = 25 °C 2 - 300 mW Ptot Tamb = 25 °C - 1090 mW Ptot drain-source voltage Tj = 25 °C - 30 V VGS gate-source voltage Tj = 25 °C 1 - 400 mA VGS gate-source voltage Tj = 25 °C 1 - 400 mA VGS gate-source voltage Tj = 25 °C 1 - 400 mA ID drain current Tamb = 25 °C; single pulse; tp ≤ 10 µs - 1.6 A Ptot total power dissipation Tamb = 25 °C 2 - 30 mW Ptot total power dissipation Ta	TR2 (P-char	nnel)				
Ib drain current VGS = -4.5 V; Tamb = 25 °C III - 1.40 mA Ib DM peak drain current Tamb = 25 °C; single pulse; tp ≤ 10 µs - 0.9 A Ptot total power dissipation Tamb = 25 °C; single pulse; tp ≤ 10 µs - 0.9 A TRI (N-channel) VDS drain-source voltage Tj = 25 °C III - 300 mW VGS gate-source voltage Tj = 25 °C - 30 V VGS gate-source voltage Tj = 25 °C III - 400 mA Ib drain current VGS = 4.5 V; Tamb = 25 °C III - 400 mA Ib drain current Tamb = 25 °C; single pulse; tp ≤ 10 µs - 1.6 A Ptot total power dissipation Tamb = 25 °C; single pulse; tp ≤ 10 µs - 1.6 A Ptot total power dissipation Tamb = 25 °C III - 300 mW Ptotal color dissipation Tamb = 25 °C III - 30 ™ Ptotal color dissipation Tamb = 25 °C III - 30 ™ Tamb	V_{DS}	drain-source voltage	T _j = 25 °C	-	-30	V
$ \begin{array}{ c c c c c } \hline & V_{GS} = -4.5 \text{ V; } T_{amb} = 100 ^{\circ}\text{C} & 1 1 - 140 $	V_{GS}	gate-source voltage		-8	8	V
IDDM peak drain current T _{amb} = 25 °C; single pulse; t _p ≤ 10 μs - -0.9 A Ptot total power dissipation T _{amb} = 25 °C ½ - 330 mW TRI (N-channel) T _{sp} = 25 °C - 1090 mW VDs drain-source voltage T _j = 25 °C - 30 V VGs gate-source voltage T _j = 25 °C - 30 V VGs gate-source voltage T _j = 25 °C - - 8 V ID drain current V _{GS} = 4.5 V; T _{amb} = 25 °C ½ - 20 mA ID peak drain current T _{amb} = 25 °C; single pulse; t _p ≤ 10 µs - 1.6 A Ptot total power dissipation T _{amb} = 25 °C ½ - 30 mW Ptot total power dissipation T _{amb} = 25 °C ½ - 50 mW Tamb total power dissipation T _{amb} = 25 °C ½ - 50	I_D	drain current	V _{GS} = -4.5 V; T _{amb} = 25 °C	<u>[1]</u> _	-220	mA
Ptot total power dissipation Tamb = 25 °C 2 ° - 330 mW mW TRI (N-cham-III) Ty = 25 °C - 1090 mW mW TRI (N-cham-III) Ty = 25 °C - 30 V V Vos gate-source voltage - - 30 V V Vos gate-source voltage - - 8 W V Ib drain current Vos = 4.5 V; Tamb = 25 °C 11 - 400 mA mA Ib peak drain current Tamb = 25 °C; single pulse; tp ≤ 10 µs - 1.6 A A Ptot total power dissipation Tamb = 25 °C; single pulse; tp ≤ 10 µs - 1.6 A A Per device 12 - 300 mW - 1.6 A A - - 1.0 mW mW - - 1.0 mW - - - 1.0 mW mW - - <td< td=""><td></td><td></td><td>V_{GS} = -4.5 V; T_{amb} = 100 °C</td><td><u>[1]</u> -</td><td>-140</td><td>mA</td></td<>			V _{GS} = -4.5 V; T _{amb} = 100 °C	<u>[1]</u> -	-140	mA
$ \begin{array}{ c c c c } \hline TR1 (N-channell - Name + N$	I _{DM}	peak drain current	T_{amb} = 25 °C; single pulse; $t_p \le 10 \mu s$	-	-0.9	А
Table Ta	P _{tot}	total power dissipation	T _{amb} = 25 °C	[2] _	330	mW
TR1 (N-channel) VDS drain-source voltage T _j = 25 °C - 30 V VGS gate-source voltage - 8 V ID drain current VGS = 4.5 V; Tamb = 25 °C 11 - 400 mA IDM peak drain current Tamb = 25 °C; single pulse; tp ≤ 10 µs - 1.6 A Ptot total power dissipation Tamb = 25 °C; single pulse; tp ≤ 10 µs - 1.6 A Ptot 12 - 330 mW Type = 25 °C 12 - 330 mW Type = 25 °C 2 - 109 mW Ptot total power dissipation Tamb = 25 °C 2 - 500 mW Type = 25 °C 10 - 500 mW Type = 25 °C 2 - 500 mW Type = 25 °C 12 - 500 °C Type = 25 °C 12 - 500 °C Type = 25 °C 11 - <td></td> <td></td> <td></td> <td><u>[1]</u> _</td> <td>390</td> <td>mW</td>				<u>[1]</u> _	390	mW
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$			T _{sp} = 25 °C	-	1090	mW
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	TR1 (N-char	nnel)				
$ \begin{array}{ c c c c c } \hline l_D & drain current & V_{GS} = 4.5 \text{ V; } T_{amb} = 25 \text{ °C} & 11 - & 400 $	V_{DS}	drain-source voltage	T _j = 25 °C	-	30	V
$ \begin{array}{ c c c c c c c c c c c c c c c c c c c$	V_{GS}	gate-source voltage		-8	8	V
$\begin{array}{ c c c c }\hline l_{DM} & peak drain current & T_{amb} = 25~^{\circ}C; single pulse; t_{p} \leq 10~\mus & - & 1.6 & A \\ \hline P_{tot} & total power dissipation & T_{amb} = 25~^{\circ}C & 2 & - & 330 & mW \\ \hline I1 & - & 390 & mW \\ \hline T_{sp} = 25~^{\circ}C & - & 1090 & mW \\ \hline Per device & & & & & & & & & & & & & & & & & & &$	I_D	drain current	$V_{GS} = 4.5 \text{ V}; T_{amb} = 25 ^{\circ}\text{C}$	<u>[1]</u> _	400	mA
$P_{tot} \text{total power dissipation} \begin{array}{c ccccccccccccccccccccccccccccccccccc$			V _{GS} = 4.5 V; T _{amb} = 100 °C	<u>[1]</u> _	260	mA
$T_{sp} = 25 ^{\circ}\text{C} \qquad \qquad - \qquad 1090 \text{mW}$ $Per \ device$ $P_{tot} \qquad total \ power \ dissipation \qquad T_{amb} = 25 ^{\circ}\text{C} \qquad \qquad 2 - \qquad 500 \text{mW}$ $T_{j} \qquad \text{junction temperature} \qquad \qquad -55 \qquad 150 ^{\circ}\text{C}$ $T_{amb} \qquad \text{ambient temperature} \qquad \qquad -55 \qquad 150 ^{\circ}\text{C}$ $T_{stg} \qquad \text{storage temperature} \qquad \qquad -65 \qquad 150 ^{\circ}\text{C}$ $TR1 \ (N-channel), \ Source-drain \ diode$ $I_{S} \qquad \text{source current} \qquad T_{amb} = 25 ^{\circ}\text{C} \qquad \qquad 1 - \qquad 400 \text{mA}$ $TR2 \ (P-channel), \ Source-drain \ diode$ $I_{S} \qquad \text{source current} \qquad T_{amb} = 25 ^{\circ}\text{C} \qquad \qquad 1 - \qquad -220 \text{mA}$ $TR1 \ N-channel), \ ESD \ maximum \ rating$ $V_{ESD} \qquad \text{electrostatic discharge voltage} \qquad HBM \qquad \qquad 3 - \qquad 2000 \text{V}$ $TR2 \ (P-channel), \ ESD \ maximum \ rating$	I_{DM}	peak drain current	T_{amb} = 25 °C; single pulse; $t_p \le 10 \mu s$	-	1.6	Α
	P _{tot}	total power dissipation	T _{amb} = 25 °C	[2]	330	mW
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$				<u>[1]</u> _	390	mW
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$			T _{sp} = 25 °C	-	1090	mW
$T_{j} \text{junction temperature} \qquad \qquad -55 150 ^{\circ}\text{C}$ $T_{amb} \text{ambient temperature} \qquad \qquad -55 150 ^{\circ}\text{C}$ $T_{stg} \text{storage temperature} \qquad \qquad -65 150 ^{\circ}\text{C}$ $TR1 \text{ (N-channel), Source-drain diode}$ $I_{S} \text{source current} \qquad T_{amb} = 25 ^{\circ}\text{C} \qquad \qquad \boxed{1} - 400 \text{mA}$ $TR2 \text{ (P-channel), Source-drain diode}$ $I_{S} \text{source current} \qquad T_{amb} = 25 ^{\circ}\text{C} \qquad \qquad \boxed{1} - -220 \text{mA}$ $TR1 \text{ N-channel), ESD maximum rating}$ $V_{ESD} \text{electrostatic discharge voltage} \text{HBM} \qquad \qquad \boxed{3} - 2000 \text{V}$ $TR2 \text{ (P-channel), ESD maximum rating}$	Per device					
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	P _{tot}	total power dissipation	T _{amb} = 25 °C	[2]	500	mW
$T_{stg} \text{storage temperature} \qquad \qquad -65 150 ^{\circ}\text{C}$ $TR1 \text{ (N-channel), Source-drain diode}$ $I_{S} \text{source current} \qquad T_{amb} = 25 ^{\circ}\text{C} \qquad \qquad \boxed{11} - 400 \text{mA}$ $TR2 \text{ (P-channel), Source-drain diode}$ $I_{S} \text{source current} \qquad T_{amb} = 25 ^{\circ}\text{C} \qquad \qquad \boxed{11} - -220 \text{mA}$ $TR1 \text{ N-channel), ESD maximum rating}$ $V_{ESD} \text{electrostatic discharge voltage} \text{HBM} \qquad \qquad \boxed{3} - 2000 \text{V}$ $TR2 \text{ (P-channel), ESD maximum rating}$	Tj	junction temperature		-55	150	°C
TR1 (N-channel), Source-drain diode I_S source current $T_{amb} = 25 ^{\circ}\text{C}$ $I_I = 400 ^{\circ}\text{mA}$ TR2 (P-channel), Source-drain diode I_S source current $T_{amb} = 25 ^{\circ}\text{C}$ $I_I = -220 ^{\circ}\text{mA}$ TR1 N-channel), ESD maximum rating V_{ESD} electrostatic discharge voltage HBM $I_I = -2000 ^{\circ}\text{V}$ TR2 (P-channel), ESD maximum rating	T _{amb}	ambient temperature		-55	150	°C
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	T _{stg}	storage temperature		-65	150	°C
TR2 (P-channel), Source-drain diode I _S source current $T_{amb} = 25 ^{\circ}\text{C}$ TR1 N-channel), ESD maximum rating V _{ESD} electrostatic discharge voltage HBM I3 - 2000 V TR2 (P-channel), ESD maximum rating	TR1 (N-char	nnel), Source-drain diode				
$I_{S} \qquad \text{source current} \qquad T_{amb} = 25 ^{\circ}\text{C} \qquad \qquad \boxed{11} - \qquad -220 \text{mA}$ $ TR1 \text{N-channel}, \text{ESD maximum rating} $ $V_{ESD} \qquad \text{electrostatic discharge voltage} \text{HBM} \qquad \qquad \boxed{3} - \qquad 2000 \text{V} $ $ TR2 \text{(P-channel)}, \text{ESD maximum rating} $	Is	source current	T _{amb} = 25 °C	<u>[1]</u> -	400	mA
TR1 N-channel), ESD maximum rating V _{ESD} electrostatic discharge voltage HBM TR2 (P-channel), ESD maximum rating	TR2 (P-char	nnel), Source-drain diode				
V _{ESD} electrostatic discharge voltage HBM [3] - 2000 V TR2 (P-channel), ESD maximum rating	Is	source current	T _{amb} = 25 °C	<u>[1]</u> _	-220	mA
TR2 (P-channel), ESD maximum rating	TR1 N-chan	nel), ESD maximum rating				
	V _{ESD}	electrostatic discharge voltage	HBM	<u>[3]</u> _	2000	V
V _{ESD} electrostatic discharge voltage HBM [3] - 2000 V	TR2 (P-char	nnel), ESD maximum rating				
- EGD STOCKETO GROWING TOTAL CONTROL OF THE CONTROL	V _{ESD}	electrostatic discharge voltage	HBM	<u>[3]</u> _	2000	V

^[1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and mounting pad for drain 1 cm².

^[2] Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper; tin-plated and standard footprint.

^[3] Measured between all pins.

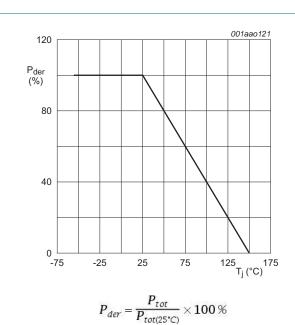


Fig 1. Normalized total power dissipation as a function of junction temperature

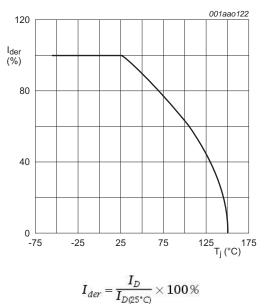
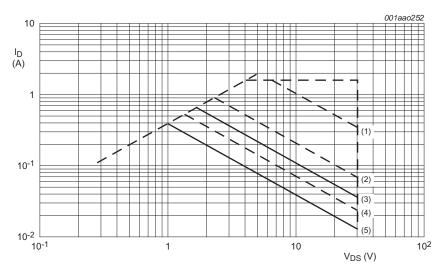


Fig 2. Normalized continuous drain current as a function of junction temperature



I_{DM} is a single pulse

(1)
$$t_p = 1 \text{ ms}$$

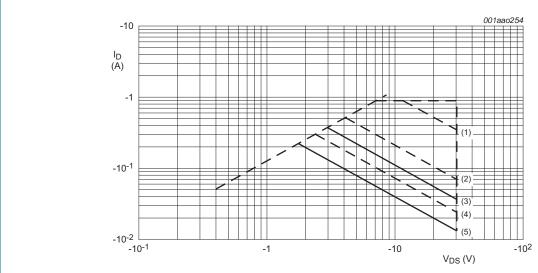
(2)
$$t_p = 10 \text{ ms}$$

(3) DC;
$$T_{sp} = 25 \, ^{\circ}\text{C}$$

(4)
$$t_p = 100 \text{ ms}$$

(5) DC; $T_{amb} = 25 \text{ °C}$; 1 cm² drain mounting pad

Fig 3. Safe operating area TR1 (N-channel); junction to ambient; continuous and peak drain currents as a function of drain-source voltage



I_{DM} is a single pulse

- (1) $t_p = 1 \text{ ms}$
- (2) $t_p = 10 \text{ ms}$
- (3) DC; $T_{sp} = 25 \, ^{\circ}\text{C}$
- (4) $t_p = 100 \text{ ms}$
- (5) DC; T_{amb} = 25 °C; 1 cm² drain mounting pad

Fig 4. Safe operating area TR2 (P-channel); junction to ambient; continuous and peak drain currents as a function of drain-source voltage

6. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
Per device							
R _{th(j-a)}	thermal resistance from junction to ambient	in free air	<u>[1]</u>	-	-	250	K/W
TR1 (N-chani	nel)						
R _{th(j-a)}	thermal resistance from junction to ambient	in free air	<u>[1]</u>	-	330	380	K/W
			[2]	-	280	320	K/W
R _{th(j-sp)}	thermal resistance from junction to solder point			-	-	115	K/W
TR2 (P-chani	nel)						
R _{th(j-a)}	thermal resistance from junction to ambient	in free air	<u>[1]</u>	-	330	380	K/W
			[2]	-	280	320	K/W
R _{th(j-sp)}	thermal resistance from junction to solder point			-	-	115	K/W

^[1] Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper; tin-plated and standard footprint.

^[2] Device mounted on an FR4 PCB, single-sided copper, tin-plated and mounting pad for drain 1 cm².

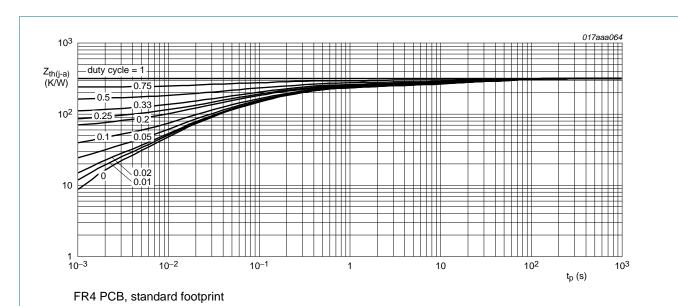


Fig 5. TR1: Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

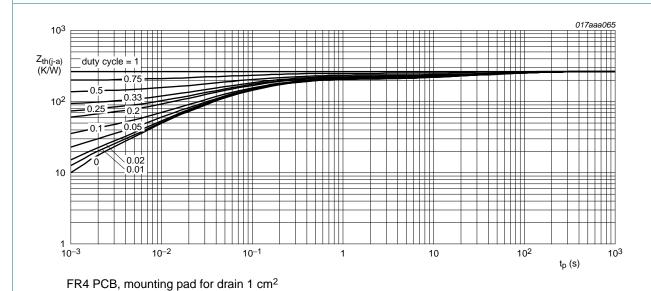


Fig 6. TR1: Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

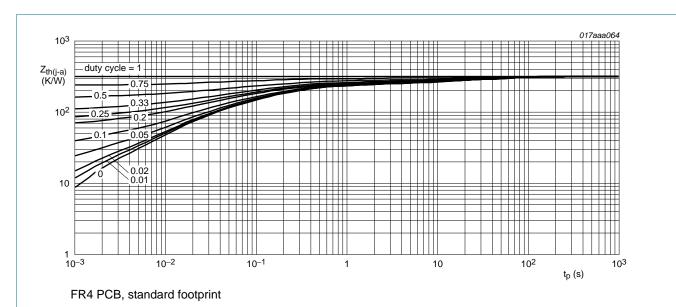


Fig 7. TR2, Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

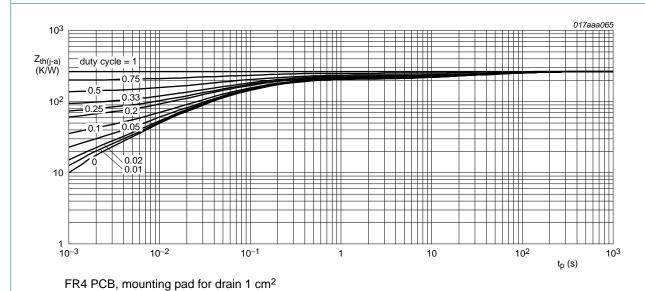


Fig 8. TR2, Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

7. Characteristics

Table 7. Characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
TR2 (P-char	nnel), Static characteristic	s				
$V_{(BR)DSS}$	drain-source breakdown voltage	$I_D = -250 \mu A; V_{GS} = 0 V; T_j = 25 °C$	-30	-	-	V
V_{GSth}	gate-source threshold voltage	$I_D = -250 \ \mu A; \ V_{DS} = V_{GS}; \ T_j = 25 \ ^{\circ}C$	-0.6	-0.9	-1.1	V
I_{DSS}	drain leakage current	$V_{DS} = -30 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	-	-1	μΑ
		$V_{DS} = -30 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 150 \text{ °C}$	-	-	-10	μΑ
I_{GSS}	gate leakage current	$V_{GS} = 8 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	-0.2	-1	μΑ
		$V_{GS} = -8 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	-0.2	-1	μΑ
		$V_{GS} = 4.5 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	-10	-	nΑ
		V_{GS} = -4.5 V; V_{DS} = 0 V; T_j = 25 °C	-	-10	-	nΑ
		$V_{GS} = 2.5 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	-1	-	nΑ
		$V_{GS} = -2.5 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	-1	-	nΑ
R _{DSon}	drain-source on-state resistance	V_{GS} = -4.5 V; I_D = -200 mA; T_j = 25 °C	-	2.8	4.1	Ω
		$V_{GS} = -2.5 \text{ V}; I_D = -10 \text{ mA}; T_j = 25 \text{ °C}$	-	5.3	6.5	Ω
		V_{GS} = -4.5 V; I_D = -200 mA; T_j = 150 °C	-	5.3	7.8	Ω
g _{fs}	transfer conductance	$V_{DS} = -10 \text{ V}; I_D = -200 \text{ mA}; T_j = 25 \text{ °C}$	-	160	-	mS
TR1 (N-chai	nnel), Static characteristic	s				
$V_{(BR)DSS}$	drain-source breakdown voltage	$I_D = 250 \mu A; V_{GS} = 0 V; T_j = 25 °C$	30	-	-	V
V_{GSth}	gate-source threshold voltage	$I_D = 250 \mu A; V_{DS} = V_{GS}; T_j = 25 \text{ °C}$	0.6	0.9	1.1	V
I _{DSS}	drain leakage current	$V_{DS} = 30 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	-	1	μΑ
		$V_{DS} = 30 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 150 \text{ °C}$	-	-	10	μΑ
I _{GSS}	gate leakage current	$V_{GS} = 8 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	0.2	1	μΑ
		$V_{GS} = -8 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	0.2	1	μΑ
		$V_{GS} = 4.5 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	10	-	nΑ
		$V_{GS} = -4.5 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	10	-	nΑ
		$V_{GS} = 2.5 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	1	-	nΑ
		$V_{GS} = -2.5 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	1	-	nΑ
R _{DSon}	drain-source on-state	$V_{GS} = 4.5 \text{ V}; I_D = 350 \text{ mA}; T_j = 25 \text{ °C}$	-	1	1.4	Ω
	resistance	$V_{GS} = 4.5 \text{ V}; I_D = 350 \text{ mA}; T_j = 150 \text{ °C}$	-	1.8	2.5	Ω
		$V_{GS} = 2.5 \text{ V}; I_D = 200 \text{ mA}; T_j = 150 \text{ °C}$	-	1.4	2.1	Ω
		$V_{GS} = 1.8 \text{ V}; I_D = 10 \text{ mA}; T_j = 25 \text{ °C}$	-	2	2.8	Ω
9 _{fs}	transfer conductance	$V_{DS} = 10 \text{ V}; I_D = 350 \text{ mA}; T_j = 25 \text{ °C}$	-	310	-	mS
TR1 (N-chai	nnel), Dynamic characteri	stics				
Q _{G(tot)}	total gate charge	$V_{DS} = 15 \text{ V}; I_D = 400 \text{ mA}; V_{GS} = 4.5 \text{ V};$	-	0.52	0.68	nC
Q _{GS}	gate-source charge	T _j = 25 °C	-	0.17	-	nC
Q_{GD}	gate-drain charge		-	0.08	-	nC

Table 7. Characteristics ... continued

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
C _{iss}	input capacitance	$V_{DS} = 15 \text{ V}; f = 1 \text{ MHz}; V_{GS} = 0 \text{ V};$	-	34	50	pF
Coss	output capacitance	T _j = 25 °C	-	6.5	-	pF
C _{rss}	reverse transfer capacitance		-	2.2	-	pF
t _{d(on)}	turn-on delay time	$V_{DS} = 20 \text{ V}; R_L = 250 \Omega; V_{GS} = 4.5 \text{ V};$	-	15	30	ns
t _r	rise time	$R_{G(ext)} = 6 \Omega; T_j = 25 °C$	-	11	-	ns
t _{d(off)}	turn-off delay time		-	69	138	ns
t _f	fall time		-	19	-	ns
TR2 (P-chani	nel), Dynamic characteri	istics				
Q _{G(tot)}	total gate charge	$V_{DS} = -15 \text{ V; } I_{D} = -200 \text{ mA;}$ $V_{GS} = -4.5 \text{ V; } T_{j} = 25 \text{ °C}$	-	0.55	0.72	nC
Q_{GS}	gate-source charge		-	0.23	-	nC
Q_{GD}	gate-drain charge		-	0.09	-	nC
C _{iss}	input capacitance	$V_{DS} = -15 \text{ V}; f = 1 \text{ MHz}; V_{GS} = 0 \text{ V};$	-	31	46	pF
C _{oss}	output capacitance	T _j = 25 °C	-	6.5	-	pF
C _{rss}	reverse transfer capacitance		-	2.3	-	pF
t _{d(on)}	turn-on delay time	V_{DS} = -20 V; R_L = 250 Ω ; V_{GS} = -4.5 V;	-	19	38	ns
t _r	rise time	$R_{G(ext)} = 6 \Omega; T_j = 25 °C$	-	30	-	ns
t _{d(off)}	turn-off delay time		-	65	130	ns
t _f	fall time		-	38	-	ns
TR2 (P-chann	nel), Source-drain diode	characteristics				
V_{SD}	source-drain voltage	$I_S = -200 \text{ mA}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-0.47	-0.88	-1.2	V
TD4 /N chan	nel), Source-drain diode	characteristics				
TRT (N-Chan	nei), oodi ce-arain diode					

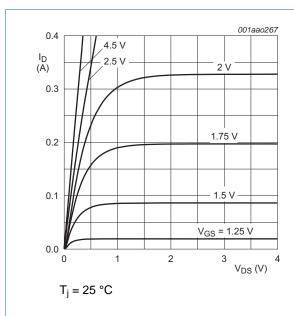
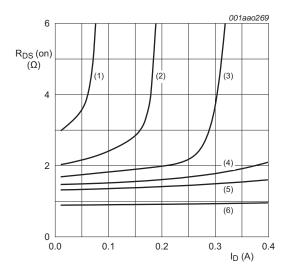


Fig 9. TR1: Output characteristics: drain current as a function of drain-source voltage; typical values



T_i = 25 °C

(1) $V_{GS} = 1.5 \text{ V}$

(2) $V_{GS} = 1.75 \text{ V}$

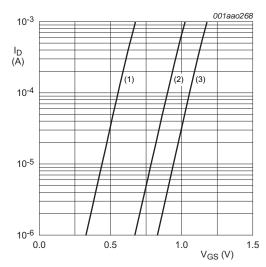
(3) $V_{GS} = 2.0 \text{ V}$

(4) $V_{GS} = 2.25 \text{ V}$

(5) $V_{GS} = 2.5 \text{ V}$

(6) $V_{GS} = 4.5 \text{ V}$

Fig 11. TR1: Drain-source on-state resistance as a function of drain current; typical values



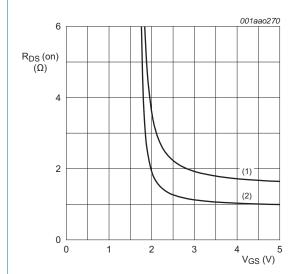
 $T_j = 25 \, ^{\circ}C; \, V_{DS} = 5 \, V$

(1) minimum values

(2) typical values

(3) maximum values

Fig 10. TR1: Sub-threshold drain current as a function of gate-source voltage

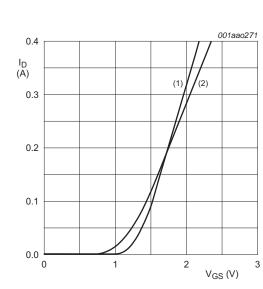


 $I_D = 400 \text{ mA}$

(1) $T_i = 150 \, ^{\circ}C$

(2) $T_i = 25 \, ^{\circ}C$

Fig 12. TR1: Drain-source on-state resistance as a function of gate-source voltage; typical values



 $V_{DS} > I_D \times R_{DSon}$

(1)
$$T_i = 25 \, ^{\circ}C$$

(2)
$$T_i = 150 \, ^{\circ}\text{C}$$

Fig 13. TR1: Transfer characteristics: drain current as a function of gate-source voltage; typical values

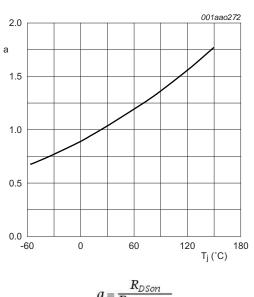
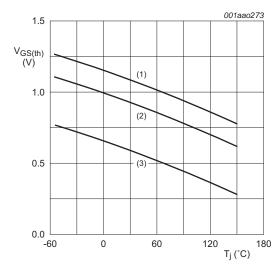


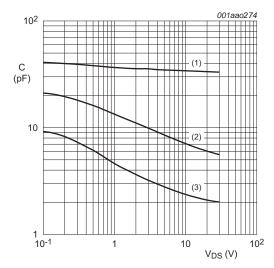
Fig 14. TR1: Normalized drain-source on-state resistance as a function of junction temperature; typical values



 $I_D = 0.25 \text{ mA}; V_{DS} = V_{GS}$

- (1) maximum values
- (2) typical values
- (3) minimum values

Fig 15. TR1: Gate-source threshold voltage as a function of junction temperature



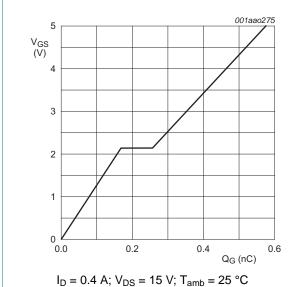
 $f = 1 MHz; V_{GS} = 0 V$

(1)C_{iss}

(2)Coss

(3)C_{rss}

Fig 16. TR1: Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values



charge; typical values



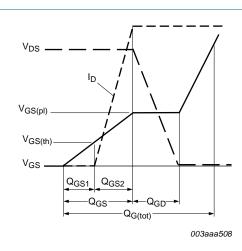
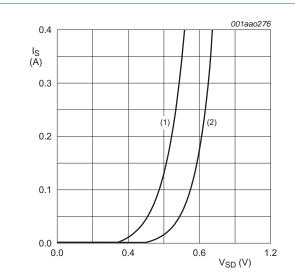


Fig 18. Gate charge waveform definitions



 $V_{GS} = 0 V$

(1)
$$T_j = 150 \, ^{\circ}C$$

(2)
$$T_i = 25 \, ^{\circ}C$$

Fig 19. TR1: Source current as a function of source-drain voltage; typical values

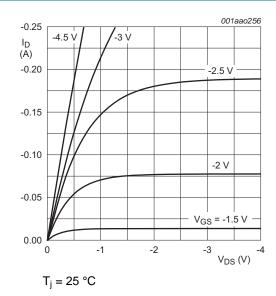
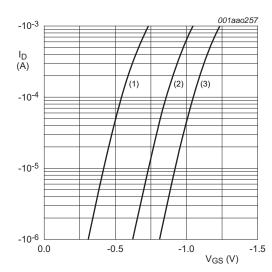
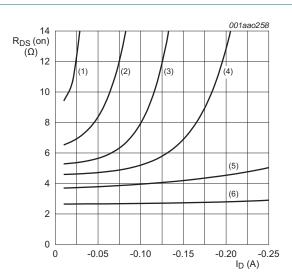


Fig 20. TR2: Output characteristics: drain current as a function of drain-source voltage; typical values



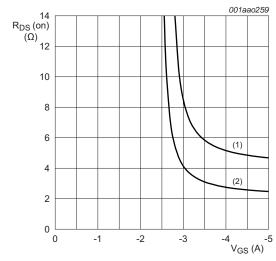
- $T_i = 25 \, ^{\circ}C; \, V_{DS} = -5 \, V$
- (1) minimum values
- (2) typical values
- (3) maximum values



- T_i = 25 °C
- (1) $V_{GS} = -1.75 \text{ V}$
- (2) $V_{GS} = -2.0 \text{ V}$
- (3) $V_{GS} = -2.25 \text{ V}$
- (4) $V_{GS} = -2.5 \text{ V}$
- (5) $V_{GS} = -3.0 \text{ V}$
- (6) $V_{GS} = -4.5 \text{ V}$

Fig 21. TR2: Sub-threshold drain current as a function of gate-source voltage



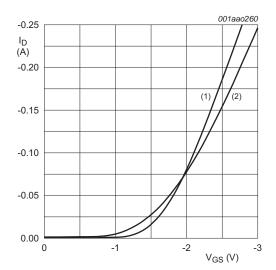


 $I_D = -200 \text{ mA}$

(1) $T_i = 150 \, ^{\circ}\text{C}$

(2) $T_i = 25 \, ^{\circ}C$

Fig 23. TR2: Drain-source on-state resistance as a function of gate-source voltage; typical values



 $V_{DS} > I_D \times R_{DSon}$

(1) $T_i = 25 \, ^{\circ}C$

(2) $T_i = 150 \, ^{\circ}\text{C}$

Fig 24. TR2: Transfer characteristics: drain current as a function of gate-source voltage; typical values

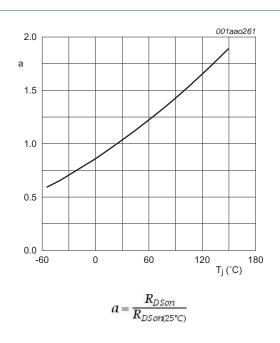
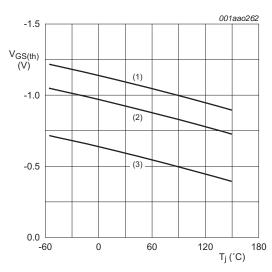


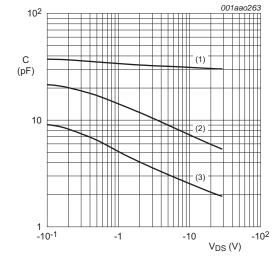
Fig 25. TR2: Normalized drain-source on-state resistance as a function of junction temperature; typical values



 I_D = -0.25 mA; V_{DS} = V_{GS}

- (1) maximum values
- (2) typical values
- (3) minimum values

Fig 26. TR2: Gate-source threshold voltage as a function of junction temperature



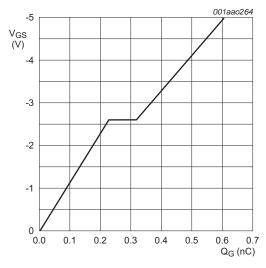
 $f = 1 \text{ MHz}; V_{GS} = 0 \text{ V}$

 $(1)C_{iss}$

(2)Coss

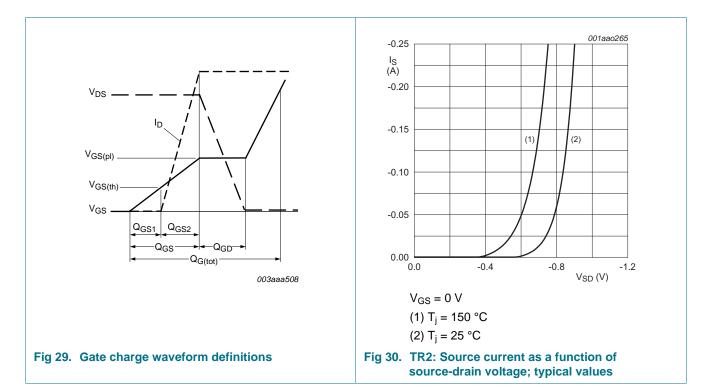
 $(3)C_{rss}$

Fig 27. TR2: Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

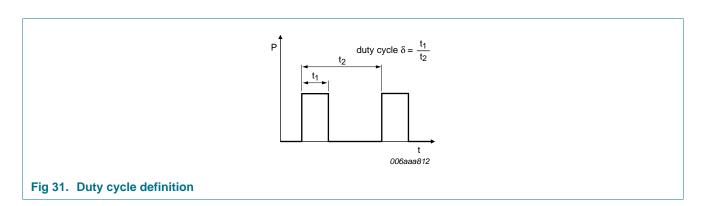


 $I_D = -200 \text{ mA}; V_{DS} = -15 \text{ V}; T_{amb} = 25 ^{\circ}\text{C}$

Fig 28. Gate-source voltage as a function of gate charge; typical values



8. Test information



8.1 Quality information

This product has been qualified in accordance with the Automotive Electronics Council (AEC) standard *Q101 - Stress test qualification for discrete semiconductors*, and is suitable for use in automotive applications.

9. Package outline

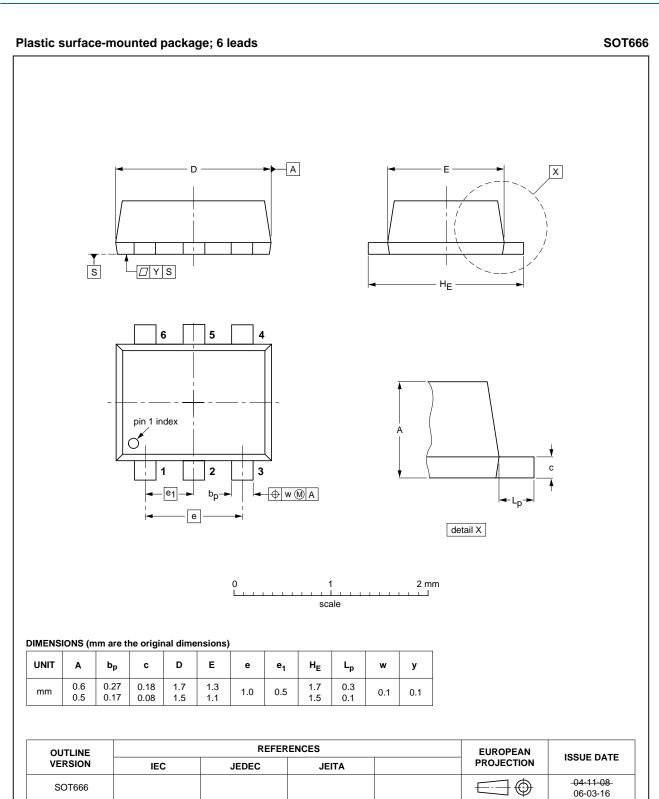
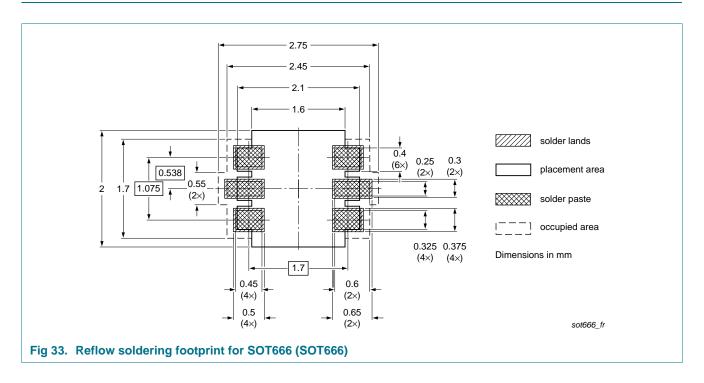


Fig 32. Package outline SOT666 (SOT666)

NX3008CBKV

10. Soldering



Nexperia NX3008CBKV

30 / 30 V, 400 / 220 mA N/P-channel Trench MOSFET

11. Revision history

Table 8. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
NX3008CBKV v.1	20110729	Product data sheet	-	-

12. Legal information

12.1 Data sheet status

Document status [1] [2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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